

MOS FIELD EFFECT TRANSISTOR

NP80N03CDE,NP80N03DDE,NP80N03EDE,NP80N03KDE

SWITCHING N-CHANNEL POWER MOS FET

30

±20

±80

±320

120

1.8

175

-55 to +175

50 / 40 / 9

2.5 / 160 / 400

W

°C

°C

DESCRIPTION

These products are N-channel MOS Field Effect Transistor designed for high current switching applications.

FEATURES

- Channel Temperature 175 degree rated
- Super Low On-state Resistance

 $R_{DS(on)1} = 7.0 \text{ m}\Omega$ MAX. (Vgs = 10 V, ID = 40 A)

 $R_{DS(on)2} = 9.0 \text{ m}\Omega$ MAX. (Vgs = 5 V, ID = 40 A)

ABSOLUTE MAXIMUM RATINGS ($T_A = 25^{\circ}C$)

• Low Ciss: Ciss = 2600 pF TYP.

Drain to Source Voltage (Vgs = 0 V)

Gate to Source Voltage (VDS = 0 V)

Drain Current (DC) (Tc = 25°C) Note1

Total Power Dissipation (Tc = 25°C)

Total Power Dissipation ($T_A = 25^{\circ}C$)

Drain Current (pulse) Note2

Channel Temperature

Storage Temperature

Single Avalanche Current Note3

Single Avalanche Energy Note3

ORDERING INFORMATION

PART NUMBER	PACKAGE
NP80N03CDE	TO-220AB
NP80N03DDE	TO-262
NP80N03EDE	TO-263 (MP-25ZJ)
NP80N03KDE	TO-263 (MP-25ZK)

(TO-220AB)



(TO-262)



(TO-263)



Notes 1. Calculated constant current according to MAX. Allowable channel temperature.

VDSS

Vgss

ID(DC)

ID(pulse)

P_{T1}

 P_{T2}

Tch

Tstg

las

Eas

- **2.** PW \leq 10 μ s, Duty cycle \leq 1%
- 3. Starting T_{ch} = 25°C, R_G = 25 Ω , V_{GS} = 20 \rightarrow 0 V (See Figure 4.)

THERMAL RESISTANCE

Channel to Case Thermal Resistance	Rth(ch-C)	1.25	°C/W
Channel to Ambient Thermal Resistance	Rth(ch-A)	83.3	°C/W

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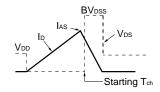


ELECTRICAL CHARACTERISTICS (TA = 25°C)

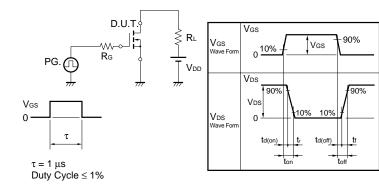
CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	IDSS	V _{DS} = 30 V, V _{GS} = 0 V			10	μΑ
Gate Leakage Current	Igss	Vgs = ±20 V, Vps = 0 V			±100	nA
Gate to Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 250 \mu\text{A}$	1.5	2.0	2.5	V
Forward Transfer Admittance	yfs	V _{DS} = 10 V, I _D = 40 A	20	41		S
Drain to Source On-state Resistance	RDS(on)1	Vgs = 10 V, ID = 40 A		5.3	7.0	mΩ
	RDS(on)2	Vgs = 5 V, ID = 40 A		6.8	9.0	mΩ
	RDS(on)3	Vgs = 4.5 V, ID = 40 A		7.5	11	mΩ
Input Capacitance	Ciss	V _{DS} = 25 V		2600	3900	pF
Output Capacitance	Coss	V _G S = 0 V		590	890	pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		270	490	pF
Turn-on Delay Time	t d(on)	V _{DD} = 15 V, I _D = 40 A		20	44	ns
Rise Time	tr	V _G S = 10 V		12	31	ns
Turn-off Delay Time	td(off)	R _G = 1 Ω		60	120	ns
Fall Time	tf			14	35	ns
Total Gate Charge 1	Q _{G1}	ID = 80 A, VDD = 24 V, VGS = 10 V		48	72	nC
Total Gate Charge 2	Q _{G2}	V _{DD} = 24 V		28	42	nC
Gate to Source Charge	Qgs	Vgs = 5 V		10		nC
Gate to Drain Charge	Q _{GD}	ID = 80 A		14		nC
Body Diode Forward Voltage	V _F (S-D)	IF = 80 A, VGS = 0 V		1.0		V
Reverse Recovery Time	trr	IF = 80 A, VGS = 0 V		34		ns
Reverse Recovery Charge	Qrr	di/dt = 100 A/μs		22		nC

TEST CIRCUIT 1 AVALANCHE CAPABILITY

$V_{GS} = 20 \rightarrow 0 \text{ V}$ $V_{GS} = 20 \rightarrow 0 \text{ V}$



TEST CIRCUIT 2 SWITCHING TIME



TEST CIRCUIT 3 GATE CHARGE

TYPICAL CHARACTERISTICS (TA = 25°C)



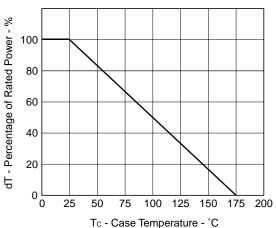


Figure 3. FORWARD BIAS SAFE OPERATING AREA

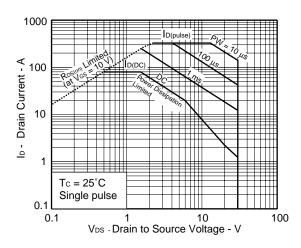


Figure2. TOTAL POWER DISSIPATION vs. CASE TEMPERATURE

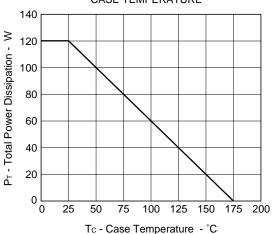


Figure 4. SINGLE AVALANCHE ENERGY DERATING FACTOR

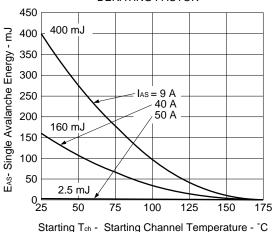


Figure 5. TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH

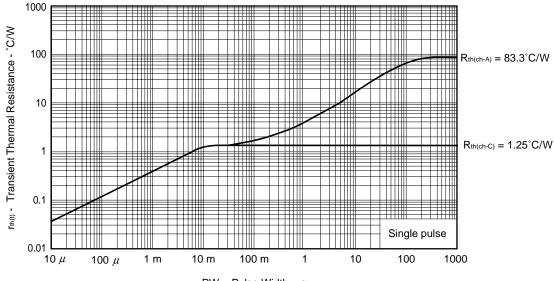


Figure 6. FORWARD TRANSFER CHARACTERISTICS

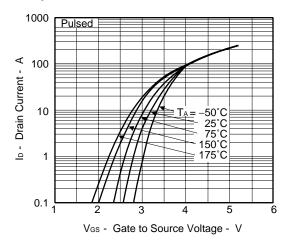


Figure 8. FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT

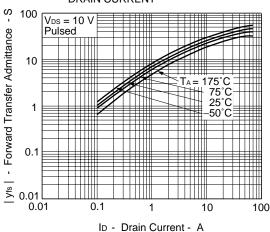


Figure 10. DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT

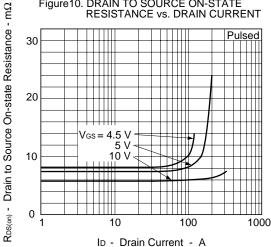


Figure 7. DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE

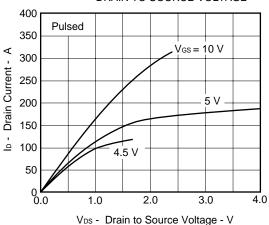


Figure 9. DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE

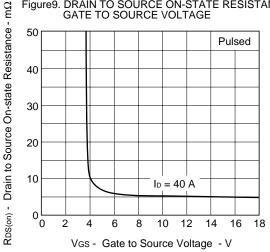
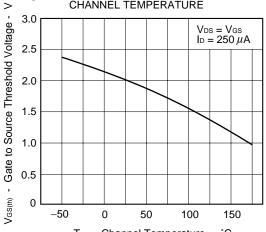
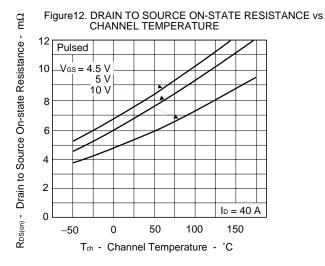
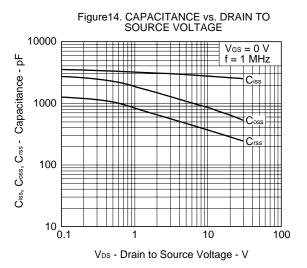
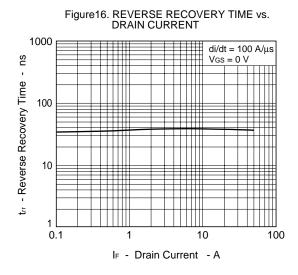


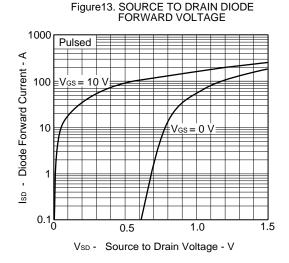
Figure 11. GATE TO SOURCE THRESHOLD VOLTAGE vs. CHANNEL TEMPERATURE

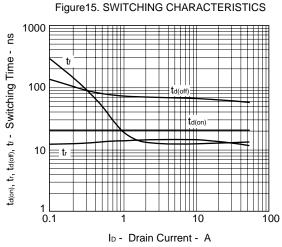


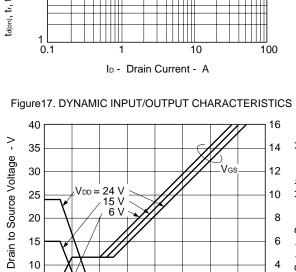








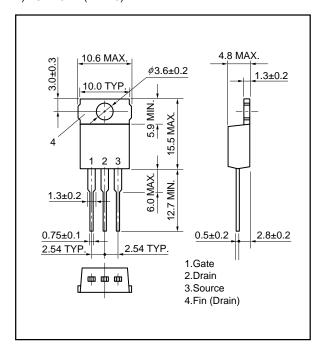




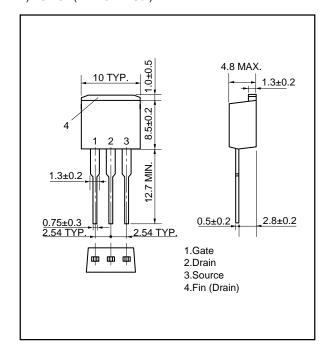
V_{DS} -

PACKAGE DRAWINGS (Unit: mm)

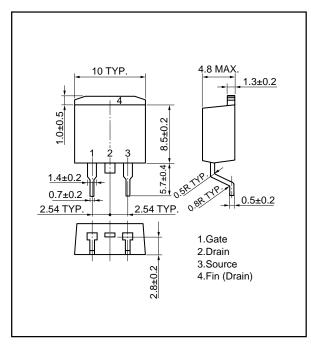
1) TO-220AB (MP-25)



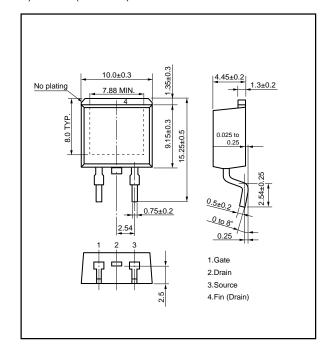
2) TO-262 (MP-25 Fin Cut)



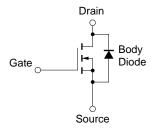
3) TO-263 (MP-25ZJ)



★ 4) TO-263 (MP-25ZK)



EQUIVALENT CIRCUIT



Remark Strong electric field, when exposed to this device, can cause destruction of the gate oxide and ultimately degrade the device operation. Steps must be taken to stop generation of static electricity as much as possible, and quickly dissipate it once, when it has occurred.

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